Sensitive Gate Silicon Controlled Rectifiers

Reverse Blocking Thyristors

PNPN devices designed for line powered consumer applications such as relay and lamp drivers, small motor controls, gate drivers for larger thyristors, and sensing and detection circuits. Supplied in surface mount package for use in automated manufacturing.

Features

- Sensitive Gate Trigger Current
- Blocking Voltage to 600 V
- Glass Passivated Surface for Reliability and Uniformity
- Surface Mount Package
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_{.I} = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1) (Sine Wave, R_{GK} = 1 kΩ $T_{.1}$ = 25 to 110°C)	V _{DRM,} V _{RRM}		V
MCR08B MCR08M		200 600	
On-State Current RMS (All Conduction Angles; T _C = 80°C)	I _{T(RMS)}	0.8	Α
Peak Non-repetitive Surge Current (1/2 Cycle Sine Wave, 60 Hz, T _C = 25°C)	I _{TSM}	8.0	Α
Circuit Fusing Considerations (t = 8.3 ms)	I ² t	0.4	A ² s
Forward Peak Gate Power (T _C = 80°C, t = 1.0 μs)	P _{GM}	0.1	W
Average Gate Power (T _C = 80°C, t = 8.3 ms)	P _{G(AV)}	0.01	W
Operating Junction Temperature Range	T _J	-40 to +110	°C
Storage Temperature Range	T _{stg}	-40 to +150	°C

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient PCB Mounted per Figure 1	$R_{\theta JA}$	156	°C/W
Thermal Resistance, Junction-to-Tab Measured on Anode Tab Adjacent to Epoxy	$R_{ heta JT}$	25	°C/W
Maximum Device Temperature for Soldering Purposes (for 10 Seconds Maximum)	T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant source such that the voltage ratings of the devices are exceeded.



ON Semiconductor®

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SCRs 0.8 AMPERES RMS 200 thru 600 VOLTS



MARKING DIAGRAM



SOT-223 CASE 318F STYLE 10



CR08x = Device Code

x = B or M

= Assembly Location

= Year W = Work Week

= Pb-Free Package (Note: Microdot may be in either location)

PIN ASSIGNMENT			
1	Cathode		
2	Anode		
3	Gate		
4	Anode		

ORDERING INFORMATION

Device	Package	Shipping [†]
MCR08BT1G	SOT-223 (Pb-Free)	1000/Tape &Reel
MCR08MT1G	SOT-223 (Pb-Free)	1000/Tape & Reel

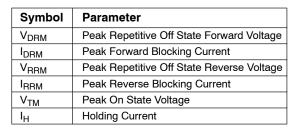
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

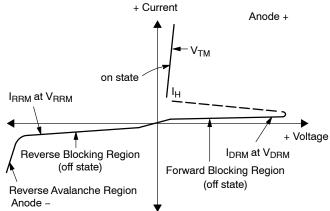
ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

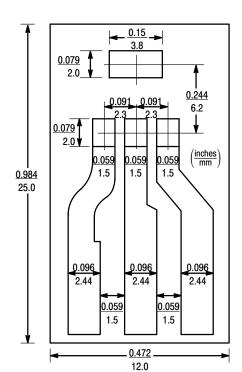
Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					
Peak Repetitive Forward or Reverse Blocking Current (Note 3) $(V_{AK} = Rated V_{DRM})$ or V_{RRM} , $R_{GK} = 1$ k Ω	I _{DRM} , I _{RRM}				
$T_J = 25^{\circ}C$ $T_J = 110^{\circ}C$:	_ _	_ _	10 200	μ Α μ Α
ON CHARACTERISTICS					
Peak Forward On-State Voltage (Note 2) (I _T = 1.0 A Peak)	V _{TM}	_	_	1.7	V
Gate Trigger Current (Continuous dc) (Note 4) (V_{AK} = 12 Vdc, R_L = 100 Ω)	I _{GT}	-	_	200	μΑ
Holding Current (Note 3) (V _{AK} = 12 Vdc, Initiating Current = 20 mA)	I _H	-	_	5.0	mA
Gate Trigger Voltage (Continuous dc) (Note 4) (V_{AK} = 12 Vdc, R_L = 100 Ω)	V _{GT}	-	_	0.8	V
Turn-On Time (V _{AK} = 12 Vdc, I _{TM} = 5 Adc, I _{GT} = 5 mA)	t _{gt}	-	1.25	-	μs
DYNAMIC CHARACTERISTICS					
Critical Rate-of-Rise of Off State Voltage $(V_{pk} = Rated\ V_{DRM}, T_C = 110^{\circ}C,\ R_{GK} = 1\ k\Omega,\ Exponential\ Method)$	dv/dt	10	-	-	V/μs

- 2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 3. R_{GK} = 1000 Ω is included in measurement.
- 4. R_{GK} is not included in measurement.

Voltage Current Characteristic of SCR







BOARD MOUNTED VERTICALLY IN CINCH 8840 EDGE CONNECTOR. BOARD THICKNESS = 65 MIL., FOIL THICKNESS = 2.5 MIL. MATERIAL: G10 FIBERGLASS BASE EPOXY

Figure 1. PCB for Thermal Impedance and Power Testing of SOT-223

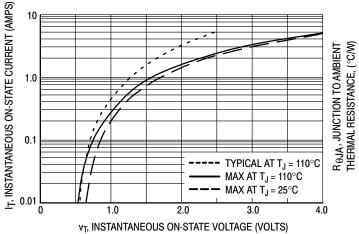


Figure 2. On-State Characteristics

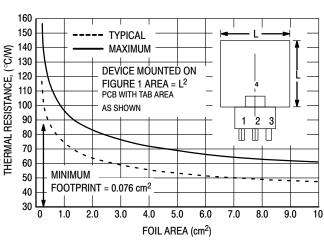


Figure 3. Junction to Ambient Thermal Resistance versus Copper Tab Area

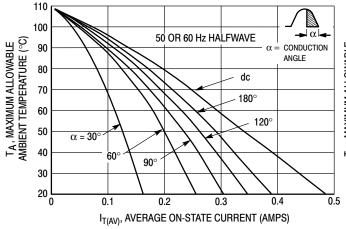


Figure 4. Current Derating, Minimum Pad Size Reference: Ambient Temperature

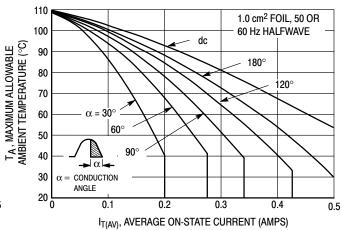


Figure 5. Current Derating, 1.0 cm Square Pad Reference: Ambient Temperature

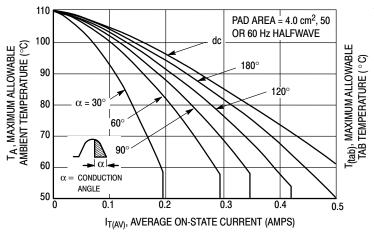


Figure 6. Current Derating, 2.0 cm Square Pad Reference: Ambient Temperature

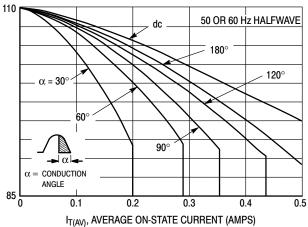


Figure 7. Current Derating Reference: Anode Tab

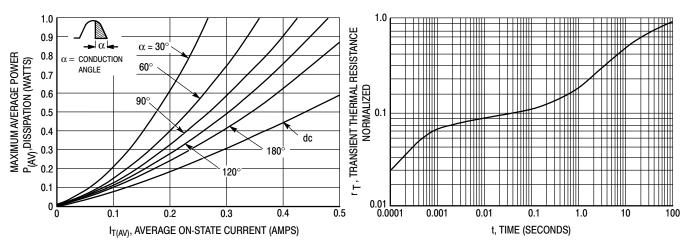


Figure 8. Power Dissipation

Figure 9. Thermal Response Device **Mounted on Figure 1 Printed Circuit Board**

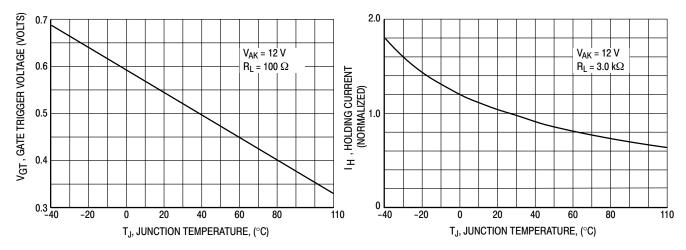


Figure 10. Typical Gate Trigger Voltage versus Junction Temperature

Figure 11. Typical Normalized Holding Current versus Junction Temperature

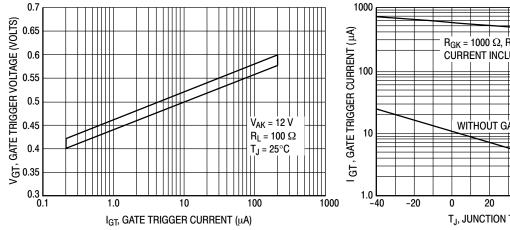


Figure 12. Typical Range of V_{GT} versus Measured I_{GT}

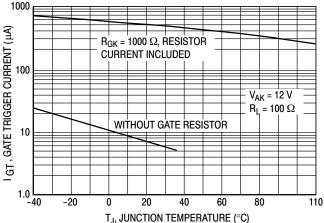


Figure 13. Typical Gate Trigger Current versus Junction Temperature

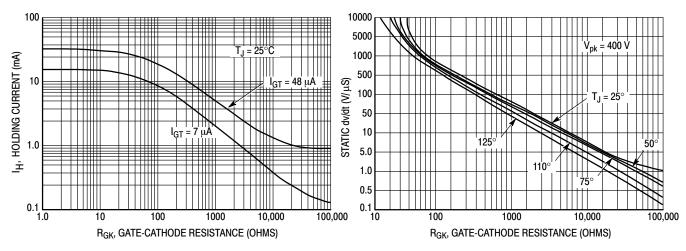


Figure 14. Holding Current Range versus Gate-Cathode Resistance

Figure 15. Exponential Static dv/dt versus Junction Temperature and Gate-Cathode Termination Resistance

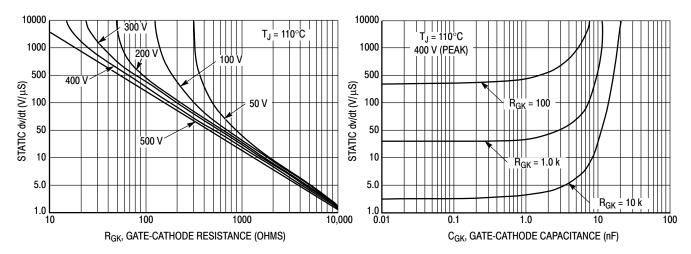


Figure 16. Exponential Static dv/dt versus Peak Voltage and Gate-Cathode Termination Resistance

Figure 17. Exponential Static dv/dt versus Gate-Cathode Capacitance and Resistance

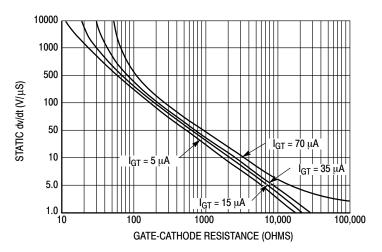
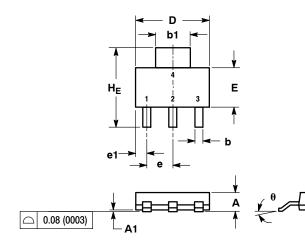


Figure 18. Exponential Static dv/dt versus Gate-Cathode Termination Resistance and Product Trigger Current Sensitivity

PACKAGE DIMENSIONS

SOT-223 (TO-261) CASE 318E-04 **ISSUE L**



NOTES: DIMENSIONING AND TOLERANCING PER ANSI Y14.5M. 1982

CONTROLLING DIMENSION: INCH.

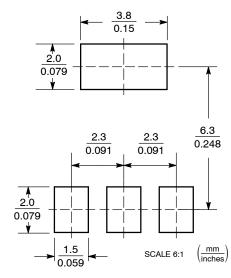
	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.50	1.63	1.75	0.060	0.064	0.068
A1	0.02	0.06	0.10	0.001	0.002	0.004
b	0.60	0.75	0.89	0.024	0.030	0.035
b1	2.90	3.06	3.20	0.115	0.121	0.126
С	0.24	0.29	0.35	0.009	0.012	0.014
D	6.30	6.50	6.70	0.249	0.256	0.263
E	3.30	3.50	3.70	0.130	0.138	0.145
е	2.20	2.30	2.40	0.087	0.091	0.094
e1	0.85	0.94	1.05	0.033	0.037	0.041
L1	1.50	1.75	2.00	0.060	0.069	0.078
HE	6.70	7.00	7.30	0.264	0.276	0.287
θ	0°	-	10°	0°	-	10°

STYLE 10:

PIN 1. CATHODE 2. ANODE

3 GATE

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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